Rev. A1, June 2003



BF245A/BF245B/BF245C

- N-Channel Amplifiers

 This device is designed for VHF/UHF amplifiers.
- Sourced from process 50.



Absolute Maximum Ratings T_a=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V_{DG}	Drain-Gate Voltage	30	V
V _{GS}	Gate-Source Voltage	-30	V
I _{GF}	Forward Gate Current	10	mA
P _D	Total Device Dissipation @T _A =25°C	350	mW
	Derate above 25°C	2.8	mW/°C
T _J , T _{STG}	Operating and Storage Junction Temperature Range	- 55 ~ 150	°C

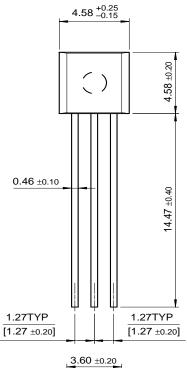
Electrical Characteristics T_a=25°C unless otherwise noted

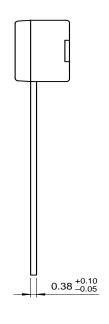
Symbol	Paran	neter	Test Condition	Min.	Max.	Units
Off Chara	cteristics		•			•
V _{(BR)GSS}	Gate-Source Breakdo	own Voltage	$V_{DS} = 0, I_{G} = 1\mu A$	-30		V
V _{GS}	Gate-Source	BF245A BF245B BF245C	$V_{DS} = 15V$, $I_D = 200\mu A$	-0.4 -1.6 -3.2	-2.2 -3.8 -7.5	V
V _{GS} (off)	Gate-Source Cut-off	Voltage	V _{DS} = 15V, I _D = 10nA	-0.5	-8	V
I _{GSS}	Gate Reverse Currer	nt	$V_{GS} = -20V, V_{GS} = 0$		-5	nA
On Chara	cteristics		·			
I _{DSS}	Zero-Gate Voltage D	rain Current BF245A BF245B BF245C	V _{GS} = 15V, V _{GS} = 0	2 6 12	6.5 15 25	mA
On Chara	cteristics		·	•	•	
9 _{fs}	Common Source For Transconductance	ward	$V_{GS} = 15V, V_{GS} = 0, f = 1KHz$	3	6.5	mmhos

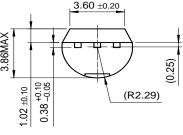
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Package Dimensions

TO-92







Dimensions in Millimeters

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CROSSVOLT™	FRFET™	MicroPak™	QFET™	SuperSOT™-8
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EcoSPARK™	GTO™	MSX™	QT Optoelectronics™	TinyLogic [®]
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EnSigna™	I ² C TM	OCX^{TM}	RapidConfigure™	UHC™
Across the board.	. Around the world.™	OCXPro™	RapidConnect™	UltraFET [®]
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PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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DISCRETE SEMICONDUCTORS

DATA SHEET

BF245A; BF245B; BF245C N-channel silicon field-effect transistors

Product specification Supersedes data of April 1995 File under Discrete Semiconductors, SC07 1996 Jul 30





N-channel silicon field-effect transistors

BF245A; BF245B; BF245C

FEATURES

- Interchangeability of drain and source connections
- Frequencies up to 700 MHz.

APPLICATIONS

• LF, HF and DC amplifiers.

DESCRIPTION

General purpose N-channel symmetrical junction field-effect transistors in a plastic TO-92 variant package.

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The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

PINNING

PIN	SYMBOL	DESCRIPTION
1	d	drain
2	s	source
3	g	gate

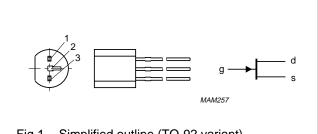


Fig.1 Simplified outline (TO-92 variant) and symbol.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage		_	_	±30	V
V_{GSoff}	gate-source cut-off voltage	I _D = 10 nA; V _{DS} = 15 V	-0.25	_	-8	V
V_{GSO}	gate-source voltage	open drain	_	_	-30	V
I _{DSS}	drain current	$V_{DS} = 15 \text{ V}; V_{GS} = 0$				
	BF245A		2	_	6.5	mA
	BF245B		6	_	15	mA
	BF245C		12	_	25	mA
P _{tot}	total power dissipation	T _{amb} = 75 °C	_	_	300	mW
y _{fs}	forward transfer admittance	V _{DS} = 15 V; V _{GS} = 0; f = 1 kHz; T _{amb} = 25 °C	3	_	6.5	mS
C _{rs}	reverse transfer capacitance	V _{DS} = 20 V; V _{GS} = -1 V; f = 1 MHz; T _{amb} = 25 °C	_	1.1	_	pF

N-channel silicon field-effect transistors

BF245A; BF245B; BF245C

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	±30	V
V_{GDO}	gate-drain voltage	open source	_	-30	V
V_{GSO}	gate-source voltage	open drain	_	-30	V
I _D	drain current		_	25	mA
I _G	gate current		_	10	mA
P _{tot}	total power dissipation	up to $T_{amb} = 75 ^{\circ}C;$	_	300	mW
		up to T _{amb} = 90 °C; note 1	_	300	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	150	°C

Note

1. Device mounted on a printed-circuit board, minimum lead length 3 mm, mounting pad for drain lead minimum $10 \text{ mm} \times 10 \text{ mm}$.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient	in free air	250	K/W
	thermal resistance from junction to ambient		200	K/W

STATIC CHARACTERISTICS

 $T_i = 25$ °C; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{(BR)GSS}	gate-source breakdown voltage	$I_G = -1 \mu A; V_{DS} = 0$	-30	_	V
V _{GSoff}	gate-source cut-off voltage	I _D = 10 nA; V _{DS} = 15 V	-0.25	-8.0	V
V_{GS}	gate-source voltage	$I_D = 200 \mu\text{A}; V_{DS} = 15 \text{V}$			
	BF245A		-0.4	-2.2	V
	BF245B		-1.6	-3.8	V
	BF245C		-3.2	-7.5	V
I _{DSS}	drain current	V _{DS} = 15 V; V _{GS} = 0; note 1			
	BF245A		2	6.5	mA
	BF245B		6	15	mA
	BF245C		12	25	mA
I _{GSS}	gate cut-off current	$V_{GS} = -20 \text{ V}; V_{DS} = 0$	_	-5	nA
ı		$V_{GS} = -20 \text{ V}; V_{DS} = 0; T_j = 125 ^{\circ}\text{C}$	_	-0.5	μΑ

Note

1. Measured under pulse conditions: t_p = 300 $\mu s;~\delta \leq 0.02.$

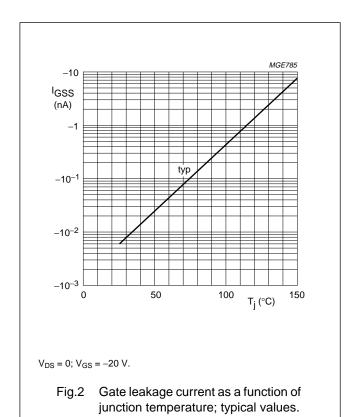
N-channel silicon field-effect transistors

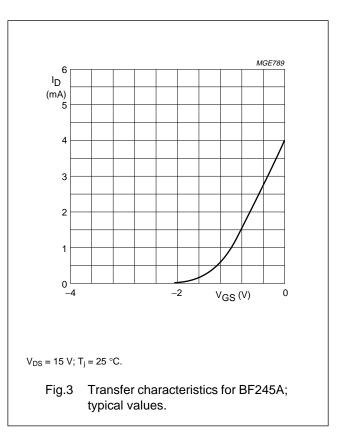
BF245A; BF245B; BF245C

DYNAMIC CHARACTERISTICS

Common source; T_{amb} = 25 °C; unless otherwise specified.

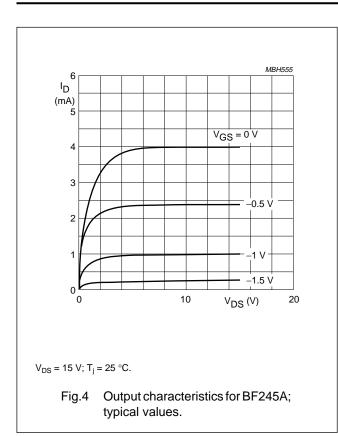
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
C _{is}	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = -1 \text{ V}; f = 1 \text{ MHz}$	_	4	_	pF
C _{rs}	reverse transfer capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = -1 \text{ V}; f = 1 \text{ MHz}$	_	1.1	_	pF
Cos	output capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = -1 \text{ V}; f = 1 \text{ MHz}$	_	1.6	_	pF
gis	input conductance	V _{DS} = 15 V; V _{GS} = 0; f = 200 MHz	_	250	_	μS
9 _{os}	output conductance	V _{DS} = 15 V; V _{GS} = 0; f = 200 MHz	_	40	_	μS
y _{fs}	forward transfer admittance	$V_{DS} = 15 \text{ V}; V_{GS} = 0; f = 1 \text{ kHz}$	3	_	6.5	mS
		V _{DS} = 15 V; V _{GS} = 0; f = 200 MHz	_	6	_	mS
y _{rs}	reverse transfer admittance	V _{DS} = 15 V; V _{GS} = 0; f = 200 MHz	_	1.4	_	mS
y _{os}	output admittance	$V_{DS} = 15 \text{ V}; V_{GS} = 0; f = 1 \text{ kHz}$	_	25	_	μS
f _{gfs}	cut-off frequency	V_{DS} = 15 V; V_{GS} = 0; g_{fs} = 0.7 of its value at 1 kHz	_	700	_	MHz
F	noise figure	V_{DS} = 15 V; V_{GS} = 0; f = 100 MHz; R_G = 1 k Ω (common source); input tuned to minimum noise	_	1.5	_	dB

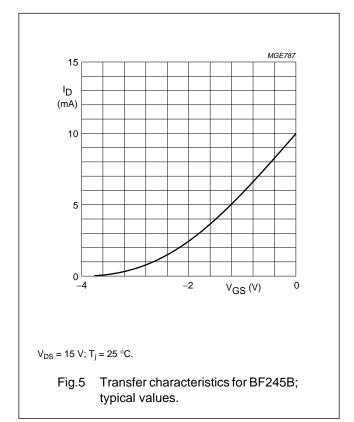


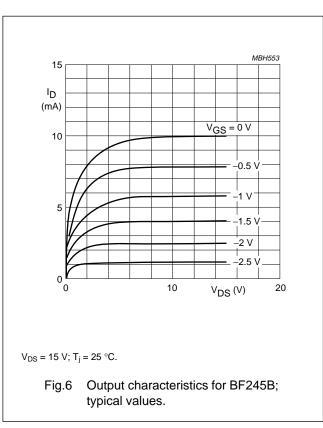


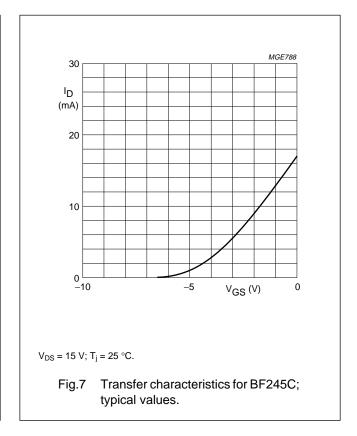
N-channel silicon field-effect transistors

BF245A; BF245B; BF245C



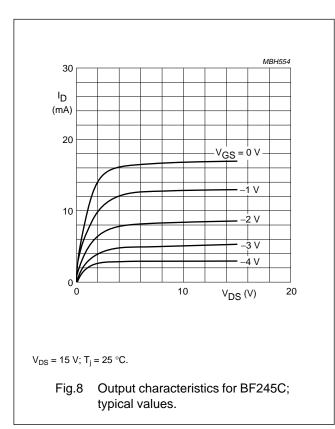


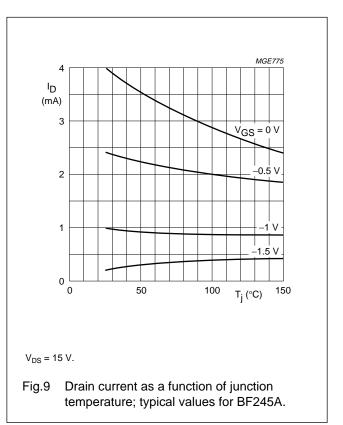


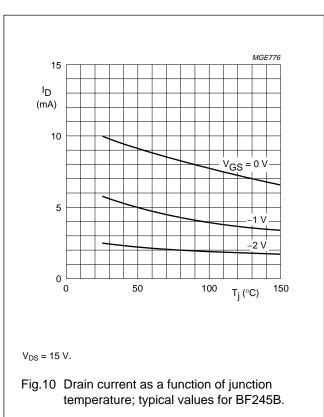


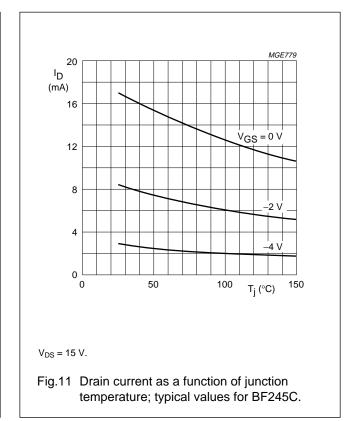
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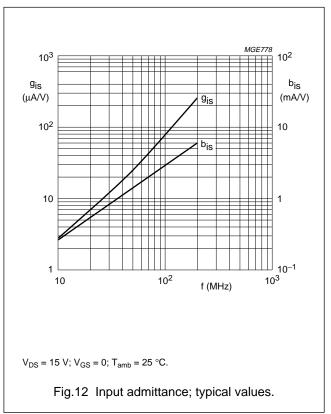


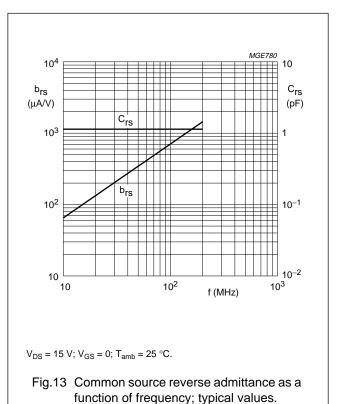


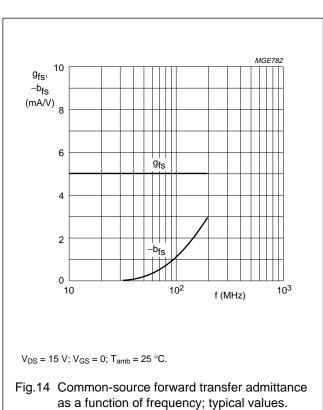


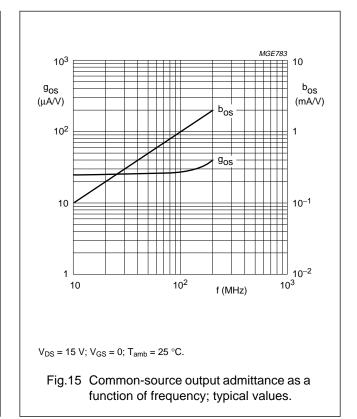
N-channel silicon field-effect transistors

BF245A; BF245B; BF245C



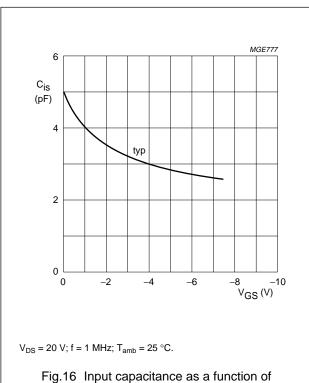






N-channel silicon field-effect transistors

BF245A; BF245B; BF245C



gate-source voltage; typical values.

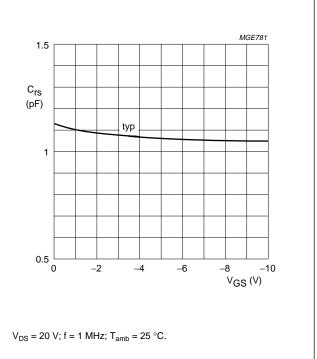
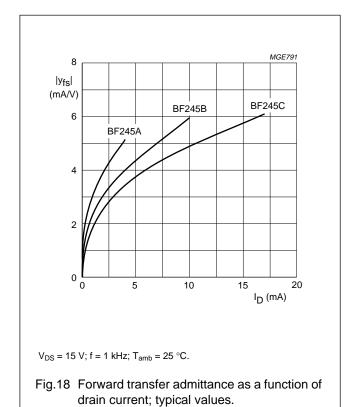
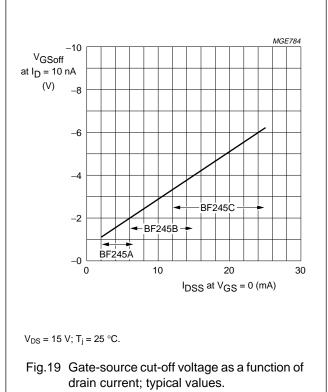


Fig.17 Reverse transfer capacitance as a function of gate-source voltage; typical values.

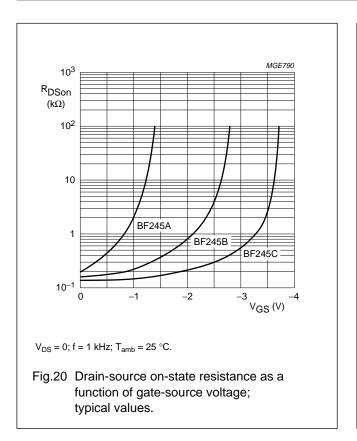




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N-channel silicon field-effect transistors

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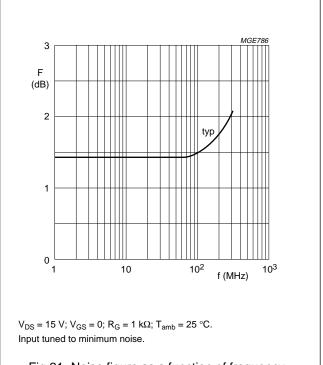
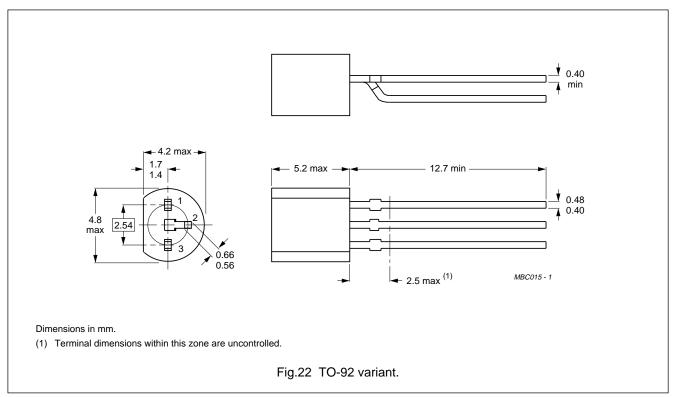


Fig.21 Noise figure as a function of frequency; typical values.

N-channel silicon field-effect transistors

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PACKAGE OUTLINE



N-channel silicon field-effect transistors

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DEFINITIONS

Data Sheet Status	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
Limiting values	

Limiting values

Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information

Where application information is given, it is advisory and does not form part of the specification.

LIFE SUPPORT APPLICATIONS

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